Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/719,874 Examiner	SATOH, TOMIO	
David Mis	2817	

	SEAR	CHED	
Class	Subclass	Date	Examiner
331	36C, 115,	5/10/2005	DM
	116R,		
	116FE,		
	132, 158,		
	159, 175,		
	177V		
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INT	ERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
as	above	5/10/2005	DM

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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